Vishay Siliconix

P-Channel 20 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	-20			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -10 \text{ V}$	0.0039			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -4.5 \text{ V}$	0.0055			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = -2.5 \text{ V}$	0.0098			
Q _g typ. (nC)	62			
I _D (A) ^a	-35			
Configuration	Single			

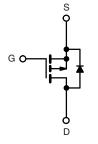
FEATURES

- TrenchFET® Gen III p-channel power MOSFET
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



APPLICATIONS

- Adaptor switch
- · Battery switch
- · Load switch



P-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK 1212-8
Lead (Pb)-free and halogen-free	Si7615DN-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V_{DS}	-20	V	
Gate-source voltage		V_{GS}	± 12	V	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		-35 ^a		
	T _C = 70 °C	1 . [-35 ^a		
	T _A = 25 °C	l _D	-22.6 ^{b, c}		
	T _A = 70 °C	† [-18.2 ^{b, c}		
Pulsed drain current (t = 100 µs)		I _{DM}	-80	A	
Continuous source-drain diode current	T _C = 25 °C		-35 ^a		
	T _A = 25 °C	ls l	-3.3 b, c		
Single pulse avalanche current	L = 0.1 mH	I _{AS}	-20		
Single pulse avalanche energy	L = U. I IIII	E _{AS}	20	mJ	
Maximum power dissipation	T _C = 25 °C		52		
	T _C = 70 °C	1 , [33	w	
	T _A = 25 °C	P _D	3.7 b, c	VV	
	T _A = 70 °C	1 [2.4 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to 150	°C	
Soldering recommendations (peak temperature) c			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, f	t ≤ 10 s	R _{thJA}	26	33	°C/W	
Maximum junction-to-case (drain)	Steady state	R _{thJC}	1.9	2.4		

Notes

- Package limited Surface mounted on 1" x 1" FR4 board
- See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

 Rework conditions: manual soldering with a soldering iron is not recommended for leadless components

 Maximum under steady state conditions is 81 °C/W

- $T_C = 25 \, ^{\circ}C$



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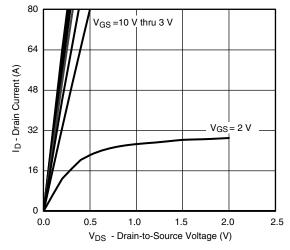
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				•	l .		
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20	-	-	٧	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	-13	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = -250 μA	-	3.7	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.4	-	-1.2	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	± 100	nA	
Zero gate voltage drain current	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$	i	-	-1	μА	
		V _{DS} = -20 V, V _{GS} = 0 V, T _J = 55 °C	i	-	-10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	-30	-	-	Α	
Drain-source on-state resistance ^a	, ,	V _{GS} = -10 V, I _D = -20 A	-	0.0031	0.0039	1	
	R _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -15 \text{ A}$	-	0.0043	0.0055	Ω	
	,	V _{GS} = -2.5 V, I _D = -10 A	-	0.0076	0.0098		
Forward transconductance ^a	9 _{fs}	$V_{DS} = -10 \text{ V}, I_D = -20 \text{ A}$	-	70	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	6000	-	pF	
Output capacitance	Coss	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	-	780	-		
Reverse transfer capacitance	C _{rss}	20 1 , de 1 ,	-	820	-		
	_	V _{DS} = -10 V, V _{GS} = -10 V, I _D = -10 A	-	122	183	nC	
Total gate charge	Q_g	50 1 00 1 0	-	62	93		
Gate-source charge	Q_{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$	-	9.4	-		
Gate-drain charge	Q_{gd}		-	17.2	-		
Gate resistance	R_g	f = 1 MHz	0.4	2	4	Ω	
Turn-on delay time	t _{d(on)}		ı	35	60		
Rise time	t _r	$V_{DD} = -10 \text{ V}, R_L = 1 \Omega, I_D \cong -10 \text{ A},$	-	38	65		
Turn-off delay time	t _{d(off)}	$V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$	ı	75	130	1	
Fall time	t _f		ı	28	55	1	
Turn-on delay time	t _{d(on)}		-	13	25	ns	
Rise time	t _r	$V_{DD} = -10 \text{ V}, R_1 = 1 \Omega, I_D \cong -10 \text{ A},$	-	8	16	- - -	
Turn-off delay time	t _{d(off)}	$V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$	-	80	150		
Fall time	t _f		-	10	20		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	Is	T _C = 25 °C		-	-35	_	
Pulse diode forward current	I _{SM}		-	-	-80	A	
Body diode voltage	V _{SD}	I _S = -4 A, V _{GS} = 0 V	-	-0.68	-1.1	V	
Body diode reverse recovery time	t _{rr}		-	36	55	ns	
Body diode reverse recovery charge	Q _{rr}		-	25	40	nC	
Reverse recovery fall time	ta	$I_F = -10 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$	-	15	-		
Reverse recovery rise time	t _b		-	21	-	ns	

Notes

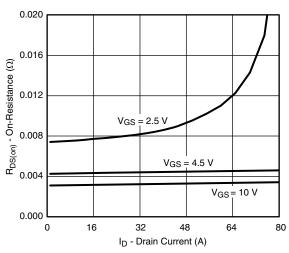
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

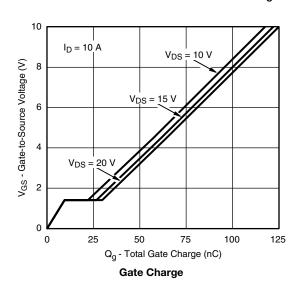


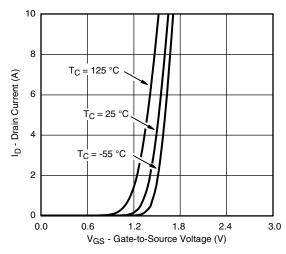


Output Characteristics

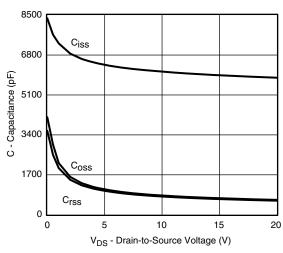


On-Resistance vs. Drain Current and Gate Voltage

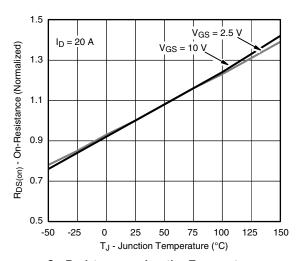




Transfer Characteristics

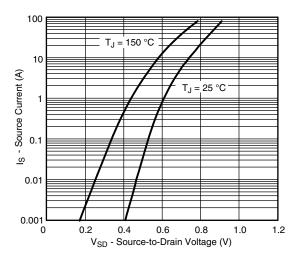


Capacitance

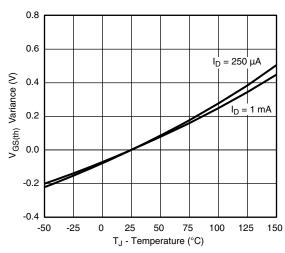


On-Resistance vs. Junction Temperature

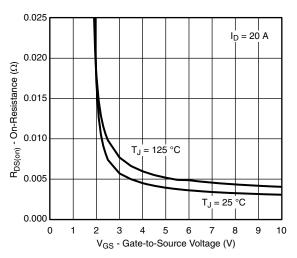




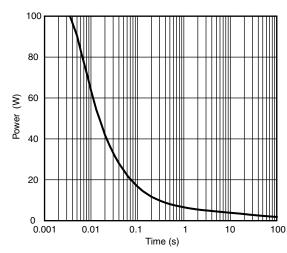
Source-Drain Diode Forward Voltage



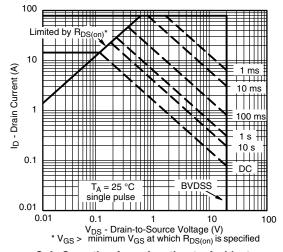
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

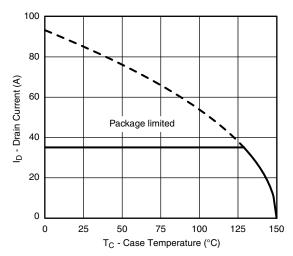


Single Pulse Power, Junction-to-Ambient

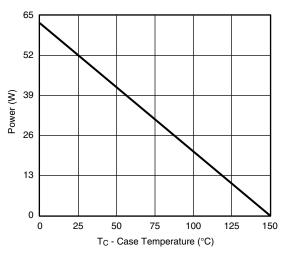


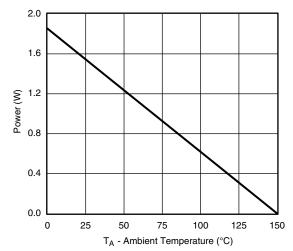
Safe Operating Area, Junction-to-Ambient





Current Derating a





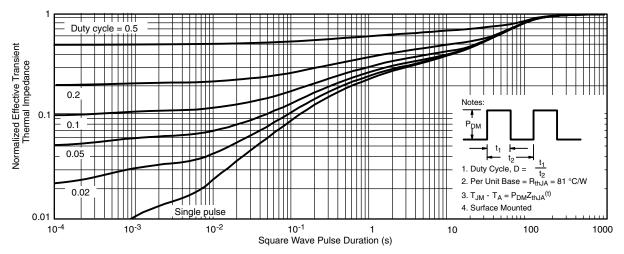
Power Derating, Junction-to-Case

Power Derating, Junction-to-Ambient

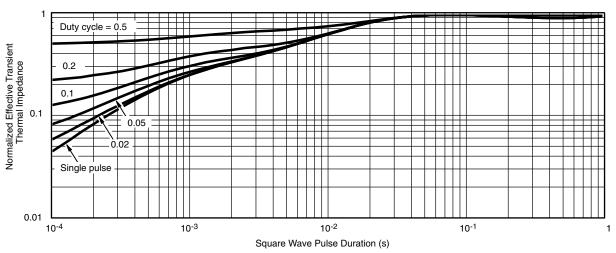
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?64722.



RECOMMENDED MINIMUM PADS FOR PowerPAK® 1212-8 Single



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOTE



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